

**Notice of References Cited**Application/Control No.  
09/783,287Applicant(s)/Patent Under  
Reexamination  
OHMI ET AL.Examiner  
Basia Ridley*BR*Art Unit  
1764

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-			
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	J	US-			
	K	US-			
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	M	US-			

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